

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/649,661	IMAI ET AL.	
Examiner	Art Unit	
CHRIS H. CHU	2874	

SEARCHED				
Class			Fugurings	
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
	Subclass	Subclass Date		

SEARCH N (INCLUDING SEAR)	IOTES CH STRATEGY	
	DATE	EXMR
applicant's cited references	10/21/2008	/CC/
text search	10/21/2008	/CC/